

# MOSFET - Power, Single N-Channel 40 V, 0.8 m $\Omega$ , 353 A

## **NVMFS5C406N**

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS5C406NWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage		$V_{DSS}$	40	V	
Gate-to-Source Voltage	te-to-Source Voltage		V <sub>GS</sub>	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	353	Α
Current R <sub>θJC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C		249	
Power Dissipation	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	179	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C	1	90	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	52	Α
Current R <sub>0JA</sub> (Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C		37	
Power Dissipation	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	3.9	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C	1	1.9	
Pulsed Drain Current	$T_A = 25$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	900	Α
Operating Junction and Range	on and Storage Temperature		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body D	iode)		IS	149	Α
Single Pulse Drain-to-S Energy (I <sub>L(pk)</sub> = 32.5 A)	Source Av	alanche	E <sub>AS</sub>	439	mJ
Lead Temperature for S (1/8" from case for 10 s)		urposes	TL	260	°C

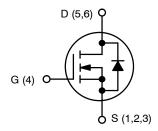
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.84	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	38.7	

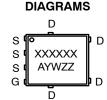
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	0.8 mΩ @ 10 V	353 A



**N-CHANNEL MOSFET** 





**MARKING** 

XXXXXX = Specific Device Code

A = Assembly Location Y = Year

Y = Year
W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

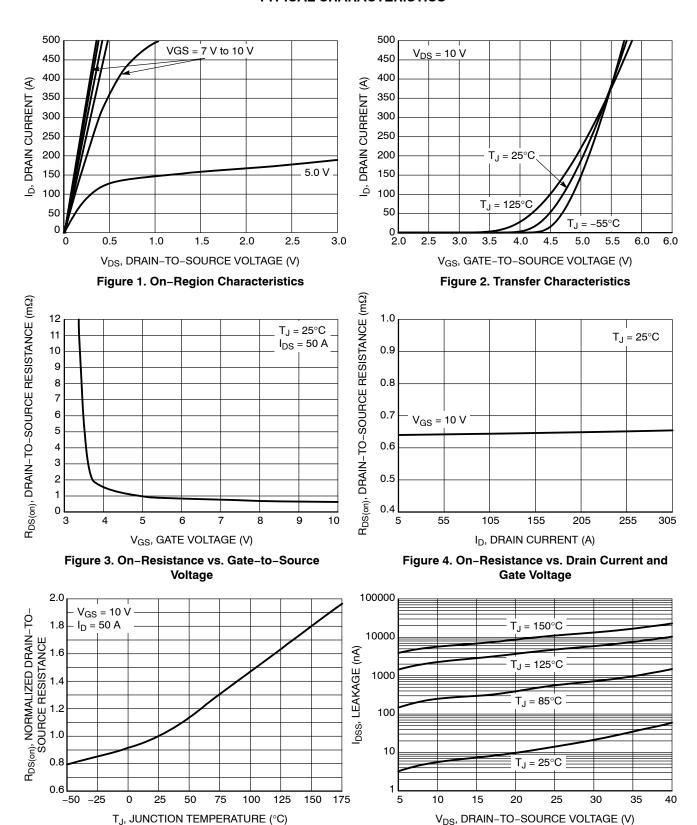
### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condit	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> =	250 μΑ	40	_	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /			-	16.7	-	mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C	-	_	10	
		V <sub>DS</sub> = 40 V	T <sub>J</sub> = 125°C	-	_	250	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= 20 V	-	_	100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	: 280 μA	2.0	-	4.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>			_	-8.0	-	mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A	_	0.64	0.8	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> =15 V, I <sub>D</sub>	= 50 A	_	190	_	S
CHARGES, CAPACITANCES & GATE RESIS	STANCE						
Input Capacitance	C <sub>ISS</sub>			-	7288	-	
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz	z, V <sub>DS</sub> = 20 V	_	4530	_	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			-	150	-	
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 20	0 V; I <sub>D</sub> = 50 A	_	110	_	
Threshold Gate Charge	Q <sub>G(TH)</sub>			_	21	_	. 0
Gate-to-Source Charge	$Q_{GS}$		2)/ 1	_	33	_	nC
Gate-to-Drain Charge	$Q_{GD}$	$V_{GS} = 10 \text{ V}, V_{DS} = 20$	J V; I <sub>D</sub> = 50 A	_	20	_	
Plateau Voltage	$V_{GP}$			_	4.7	_	V
SWITCHING CHARACTERISTICS (Note 5)							
Turn-On Delay Time	t <sub>d(ON)</sub>			-	48	-	
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub>	s = 32 V,	-	116	-	1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 50 \text{ A}, R_G =$	2.5 Ω	-	133	-	ns
Fall Time	t <sub>f</sub>			-	52	-	
DRAIN-SOURCE DIODE CHARACTERISTIC	cs						
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C	-	0.78	1.2	
		I <sub>S</sub> = 50 A	T <sub>J</sub> = 125°C	-	0.64	-	V
Reverse Recovery Time	t <sub>RR</sub>		-	-	82	-	
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dIS/dt =	: 100 A/μs,	-	39	-	ns
Discharge Time	t <sub>b</sub>	$I_S = 50 A$		-	43	-	
Reverse Recovery Charge	Q <sub>RR</sub>			_	120	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

<sup>5.</sup> Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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Figure 6. Drain-to-Source Leakage Current

vs. Voltage

Figure 5. On-Resistance Variation with

**Temperature** 

#### **TYPICAL CHARACTERISTICS**

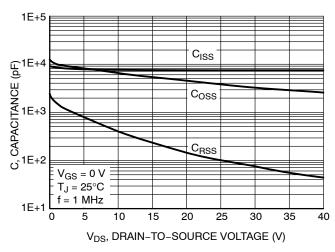


Figure 7. Capacitance Variation

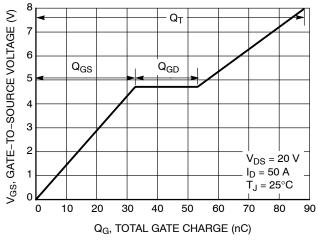


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

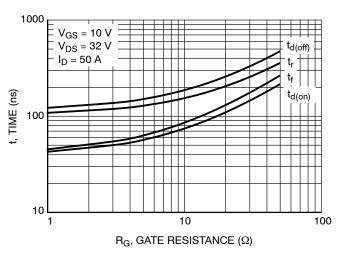


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

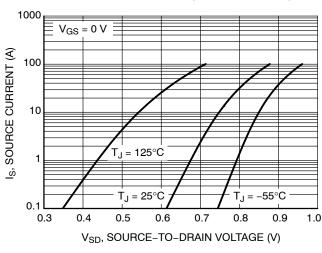


Figure 10. Diode Forward Voltage vs. Current

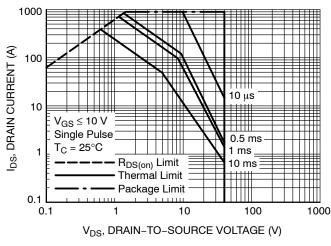


Figure 11. Maximum Rated Forward Biased Safe Operating Area

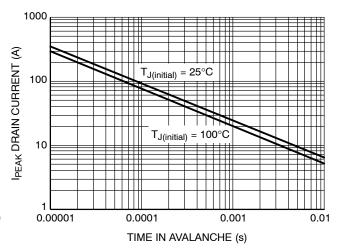


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

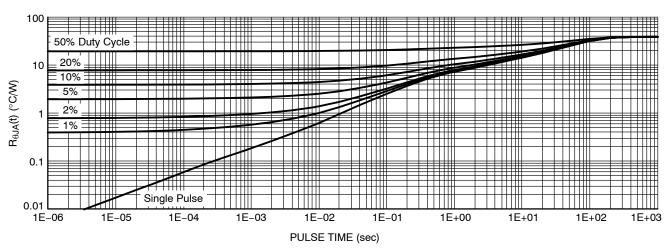


Figure 13. Thermal Characteristics

#### **DEVICE ORDERING INFORMATION**

Device	Case	Marking	Package	Shipping <sup>†</sup>
NVMFS5C406NT1G	506EZ	5C406N	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5C406NWFT1G	507BA	406NWF	DFNW5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

SCALE 2:1





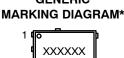
**DATE 25 AUG 2021** 

**MILLIMETERS** 

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
  2. CONTROLLING DIMENSION: MILLIMETERS
  3. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

	d I III					
			DIM	I MIN.	N□M.	MAX.
PIN 1 IDENTIFIER —			э <b>А</b>	0.90	1.00	1.10
1	i i	i	A1	0.00		0.05
			b	0.33	0.41	0.51
٩			_ c	0.23	0.28	0.33
·		A1-J I V	ם ו	5.00	5.15	5.30
	TOP VIEW		EATING D1	4.70	4.90	5.10
	101 112 11		D2	3.80	4.00	4.20
	DETAIL A —		E	6.00	6.15	6.30
// 0.10 C	$\overline{}$		E1	5.70	5.90	6.10
4		<b>‡</b>	E2	3.45	3.80	3.85
□ 0.10 C			е		1.27 BSC	,
	SIDE VIEW	SEATING C PLANE	G	0.51	0.575	0.71
	OIDL VILW		k	1.10	1.20	1.40
8X b	-		L	0.51	0.575	0.71
⊕ 0.10 C A B 0.05 C			L1		0.125 RE	F
[ * [0.05[C]	<del>   </del> e		М	3.00	3.40	3.80
	<del>    e/2</del>		θ	0*		12*
<u>1</u> 		K	2X 0.4950-	2× 1.53-	.56 <del></del>	
i 🕏	<del></del>	PACKAGE	2X 0.25-	刑	<del> </del>	

(EXPOSED PAD) **GENERIC** BOTTOM VIEW



PACKAGE DUTLINE

2X 0.91

0.97

4X 1.00

4X 0.75-



= Year

= Work Week

Α Υ

W

ZZ

= Assembly Location

RECOMMENDED MOUNTING FOOTPRINT

\_ 1.27 PITCH

For additional information on our Pb-Free strategy and soldering details, please download the IN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

= Lot Traceability \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■" may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON24855H	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED"	
DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1

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**IDENTIFIER** 

// 0.10 C

○ 0.10 C





CASE 507BA **ISSUE A** 



MILLIMETERS



TES:

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.

CONTROLLING DIMENSION: MILLIMETERS

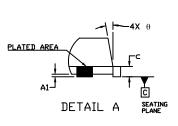
DIMENSIONS DI AND EI DO NOT INCLUDE MOLD FLASH,

PROTRUSIONS, OR GATE BURRS.

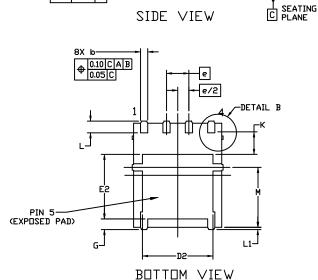
THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN

FEATURES TO AID IN FILLET FORMATION ON THE LEADS

DURING MOUNTING.



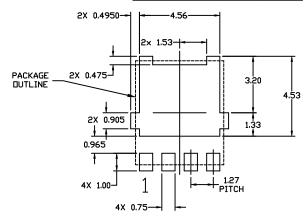
	1.171		\3
DIM	MIN.	N□M.	MAX.
Α	0.90	1.00	1.10
A1	0.00		0.05
b	0.33	0.41	0.51
C	0.23	0.28	0.33
D	5.00	5.15	5.30
D1	4.70	4.90	5.10
D2	3.80	4.00	4.20
Ε	6.00	6.15	6.30
E1	5.70	5.90	6.10
E2	3.45	3.65	3.85
e	1.27 BSC		
G	0.51	0.575	0.71
K	1.20	1.35	1.50
L	0.51	0.575	0.71
L1	0.150 REF		
М	3.00	3.40	3.80



TOP VIEW

DETAIL A





θ

0\*

12\*

#### **GENERIC** MARKING DIAGRAM\*



= Assembly Location Α Υ = Year

W = Work Week ZZ = Lot Traceability

XXXXXX = Specific Device Code \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products

may not follow the Generic Marking.

RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the  $\square N$ Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

DOCUMENT NUMBER: 98AON26450
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